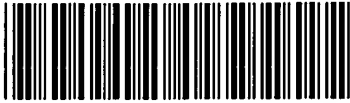


Search Notes

Application/Control No.

09/632,774

Examiner

Tri V. Nguyen

Applicant(s)/Patent under
Reexamination

HAITSUKA ET AL.

Art Unit

3622

SEARCHED

Class	Subclass	Date	Examiner
705	14	1/23/2006	NVT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (pg-pub; uspat; derwent; usocr; ibm_tdb; epo; jpo). Updated.	1/19/2006	NVT